TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC7SL08F, TC7SL08FU

2-INPUT AND GATE

The TC7SL08 is a low voltage operative C²MOS 2-INPUT AND GATE fabricated with silicon gate C²MOS technology.

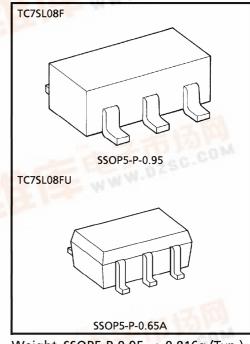
Operating voltage (V_{CC} (opr)) is 1~3V equivalent to 1pc or 2pcs of dry cell battery and it achives low power dissipation.

The internal circuit is composed of 3 stages including buffer output, which enables high noise immunity and stable output.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES

- High Speed t_{pd} = 10ns (Typ.)
 at V_{CC} = 3V
- Low Power Dissipation $I_{CC} = 1\mu A$ (Max.) at $Ta = 25^{\circ}C$
- High Noise Immunity ··············· V_{NIH} = V_{NIL}
 = 28% V_{CC} (Min.)
- Symmetrical Output Impedance ······ |I_{OH}| = I_{OL} = 1mA
- Balanced Propagation Delay Time … tpLH≒tpHL
- Low Voltage Operating V_{CC} (opr) = 1~3.6V

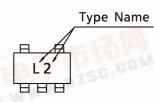


Weight SSOP5-P-0.95 : 0.016g (Typ.) SSOP5-P-0.65A : 0.006g (Typ.)

MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	V _C C	-0.5~5	V
DC Input Voltage	VIN	-0.5~V _{CC} +0.5	V
DC Output Voltage	Vout	-0.5~V _{CC} +0.5	V
Input Diode Current	ΙΚ	± 20	mA
Output Diode Current	loк	± 20	mA
DC Output Current	IOUT	± 12.5	mA
DC V _{CC} / Ground Current	lcc	± 25	mA
Power Dissipation	PD	200	mW
Storage Temperature	T _{stg}	-65~150	°C
Lead Temperature (10s)	TL	260	°C

MARKING

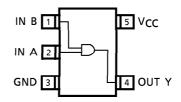




LOGIC DIAGRAM

PIN CONNECTION (TOP VIEW)





RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	Vcc	1~3.6	V
Input Voltage	VIN	0~V _{CC}	V
Output Voltage	Vout	0~V _{CC}	\
Operating Temperature	T _{opr}	- 40∼85	°C
		$0 \sim 1000 (V_{CC} = 1.0V)$	
Input Rise and Fall Time	t _r , t _f	0∼ 500 (V _{CC} = 1.5V)	ns
		0~ 400 (V _{CC} = 3.0V)	

DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	TEST	TEST		Ta = 25		C Ta = -40~85°C		UNIT							
CHARACTERISTIC	STIVIBOL	CIR- CUIT	TEST CONDITION		Vcc	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT					
High-Level Input					1.0	0.75	_	_	0.75	-						
Voltage	VIH	—		_	1.5	1.05	—	_	1.05	—	V					
Voltage	Voltage				3.0	2.10		_	2.10	_						
Low-Level Input					1.0	—	—	0.25	—	0.25						
Voltage	V _{IL}	—	.	_	1.5	—	—	0.45	—	0.45	V					
Voltage					3.0	_	_	0.90	_	0.90						
					1.0	0.9	1.0	_	0.9	—						
High-Level			loi	$I_{OH} = -20\mu A$	1.5	1.4	1.5	_	1.4	—						
Output Voltage	Voн	—	$V_{IN} = V_{IH}$	IN=VIH	3.0	2.9	3.0	_	2.9		V					
Output voltage			IOH:	$I_{OH} = -1mA$	1.5	1.07	1.23	_	0.99	—						
									$I_{OH} = -2.6mA$	3.0	2.61	2.68	_	2.55	—	
			V. V. IOI		1.0	_	0.0	0.1	_	0.1						
Low-Level				$I_{OL} = 20 \mu A$	1.5	—	0.0	0.1	—	0.1						
Output Voltage	VOL	—	V _{IN} = V _{IH} or V _{IL}		3.0	_	0.0	0.1	—	0.1	V					
Output voltage			OI VIL	$I_{OL} = 1mA$	1.5	_	0.23	0.31	—	0.37						
				$I_{OL} = 2.6 mA$	3.0	_	0.23	0.31	—	0.33						
Input Leakage Current	IIN		V _{IN} = V _{CC}	or GND	3.6	_	_	± 0.1	_	± 1.0						
Quiescent Supply Current	l _{CC}	_	$V_{IN} = V_{CC}$	or GND	3.6	_	_	1.0	_	10.0	μΑ					

TOSHIBA TC7SL08F/FU

AC ELECTRICAL	CHARACTERISTICS ($C_1 = 15pF$.	Input $t_r = t_f = 6ns$	$V_{CC} = 3.3 \pm 0.3 \text{V}$
TO ELECTIVICATE	C: 17 (10) (C: E: (15): 1C5 (C - JP /		, • (

CHARACTERISTIC SYMBO	SVMPOL	TEST	TEST CONDITION	7	UNIT			
CHARACTERISTIC	3 TIVIBOL	CUIT	TEST CONDITION		TYP.	MAX.	CIVIT	
Output Transition	^t TLH		<u></u>		5.0	9.0	ns	
Time	tTHL		_		3.0	3.0	113	
Propagation	t _{PLH}		_		7.5	13.0	ns	
Delay Time	tPHL		_		′.5	13.0	''3	

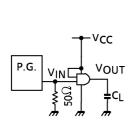
AC ELECTRICAL CHARACTERISTICS ($C_L = 25pF$, Input $t_r = t_f = 6ns$)

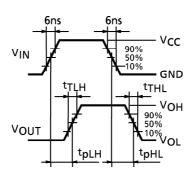
CHARACTERISTIC	SYMBOL	TEST	TEST CONDITION _		Ta = 25°C			Ta = -4		
CHARACTERISTIC	STIVIBOL	CIR- CUIT	TEST CONDITION	Vcc	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
Output Transition	+			1.0	_	70	170	_	240	
Time		—	_	1.5	—	25	45	_	55	ns
Time	^t THL			3.0	—	10	15		20	
Propagation	+			1.0	_	70	170	_	210	
Propagation Delay Time	t _{PLH}	_	_	1.5	 	25	45		55	ns
Delay Tille	t _{PHL}			3.0	_	10	15	_	20	
Input Capacitance	C _{IN}	1	1		_	5	10	_	10	
Power Dissipation Capacitance	C _{PD}	1	Note (1)			10	_			pF

Note (1): C_{PD} defined as the value of internal equivalent capacitance of IC which is calculated from the operating current consumption without load (refer to Test Circuit).

Average operating current can be obtained by the equation as follows. $I_{CC}(opr) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

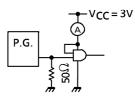
SWITCHING CHARACTERISTICS TEST CIRCUIT





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ICC (opr) TEST CIRCUIT

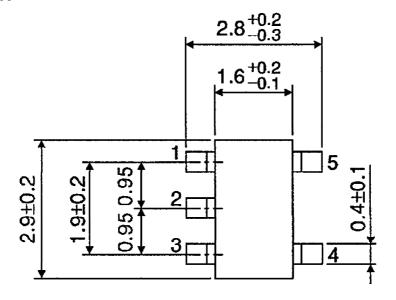


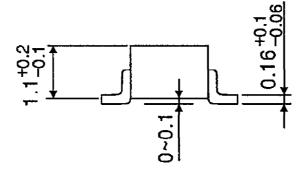
Input waveform is the same as that in case of switching characteristics test.

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PACKAGE DIMENSIONS SSOP5-P-0.95

Unit: mm



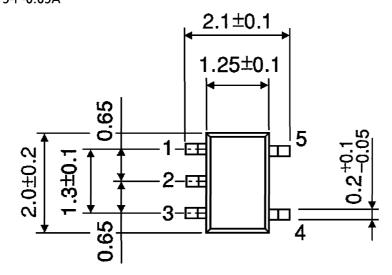


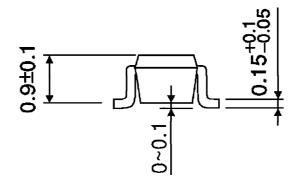
Weight: 0.016g (Typ.)

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PACKAGE DIMENSIONS SSOP5-P-0.65A

Unit: mm





Weight: 0.006g (Typ.)

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